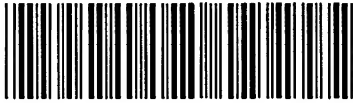


**Search Notes**

Application/Control No.

10/623,418

Examiner

Nhan T. Tran

Applicant(s)/Patent under  
Reexamination

OHKAWA, NARUMI

Art Unit

2622

**SEARCHED**

Class	Subclass	Date	Examiner
348	302, 308	2/28/2007	NT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
PGPUB text search - see search history printout		3/1/2007	NT

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search (USPAT, PGPUB, JPO, EPO, DERWENT, IBM_TDB)	2/27/2007	NT
348/294-324 (text search - see search history printout)	2/28/2007	NT
257/290-292 (text search - see search history printout)	3/1/2007	NT
250/208.1 (text search - see search history printout)	3/1/2007	NT
Search all classes 348, 257 and 250	3/1/2007	NT
Inventorship search - see search history printout	3/1/2007	NT